

10/581394

Form PTO-1449
(REV. 1/06)US Dept. of Commerce
PATENT & TRADEMARK OFFICEATTY DOCKET NO.
128094APPLICATION NO.
New U.S. National
Stage of
PCT/JP2004/018095

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANTS
Satoshi AOYAMA et al.FILING DATE
June 2, 2006

IAPC Rec'd PCT/JP 02 JUN 2006

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Date: June 2, 2006